

Application/Control No.	Applicant(s)/Patent under Reexamination
10/644,290	KANG ET AL.
Examiner	Art Unit
Thuy V. Tran	2821

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SEARCHED					
Class	Subclass	Date	Examiner		
*	Updated Search	4/12/2005	T.T.		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

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